



FQB22P10 / FQI22P10

100V P-Channel MOSFET

General Description

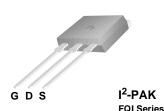
These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

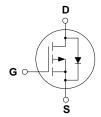
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

Features

- -22A, -100V, $R_{DS(on)} = 0.125\Omega @V_{GS} = -10 V$
- Low gate charge (typical 40 nC)
- Low Crss (typical 160 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- 175°C maximum junction temperature rating
- · RoHS Compliant







Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQB22P10 / FQI22P10	Units
V _{DSS}	Drain-Source Voltage		-100	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		-22	Α
			-15.6	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	-88	Α
V_{GSS}	Gate-Source Voltage		±30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		710	mJ
I _{AR}	Avalanche Current	(Note 1)	-22	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	12.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-6.0	V/ns
P _D	Power Dissipation (T _A = 25°C) *		3.75	W
	Power Dissipation (T _C = 25°C)		125	W
	- Derate above 25°C		0.83	W/°C
T_J , T_{STG}	Operating and Storage Temperature Range		-55 to +175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

Symbol	Parameter	Test Conditions	;	Min	Тур	Max	Units
Off Cha	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$		-100			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$, Referenced	to 25°C		-0.1		V/°C
I _{DSS}	Zura Outa Wallana Brain Our	V _{DS} = -100 V, V _{GS} = 0 V				-1	μΑ
	Zero Gate Voltage Drain Current	$V_{DS} = -80 \text{ V}, T_{C} = 125^{\circ}\text{C}$				-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
On Cha	aracteristics						,
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250 μA		-2.0		-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -11 A			0.096	0.125	Ω
9 _{FS}	Forward Transconductance	V _{DS} = -40 V, I _D = -11 A	(Note 4)		13.5		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			1170 460 160	1500 600 200	pF pF pF
Switchi	ing Characteristics						
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -50 \text{ V}, I_{D} = -22 \text{ A},$ $R_{G} = 25 \Omega$			17	45	ns
t _r	Turn-On Rise Time				170	350	ns
t _{d(off)}	Turn-Off Delay Time				60	130	ns
t _f	Turn-Off Fall Time		(Note 4, 5)		110	230	ns
Qg	Total Gate Charge	$V_{DS} = -80 \text{ V}, I_{D} = -22 \text{ A},$			40	50	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V			7.0		nC
Q _{gd}	Gate-Drain Charge		(Note 4, 5)		21		nC
Drain-S	Source Diode Characteristics at Maximum Continuous Drain-Source Dio		S			-22	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				-88	Α	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -22 \text{ A}$				-4.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_S = -22 \text{ A,}$ $dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)			110		ns
Q _{rr}	Reverse Recovery Charge				0.6		μС

- 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 2.2mH, $|_{AS}$ = -22A, V_{DD} = -25V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3. $|_{SD}$ \leq -22A, di/dt \leq 300A/µs, V_{DD} \leq BV $_{DSS}$, Starting T_{J} = 25°C 4. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

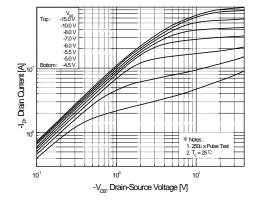


Figure 1. On-Region Characteristics

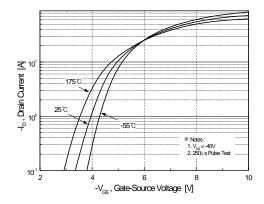


Figure 2. Transfer Characteristics

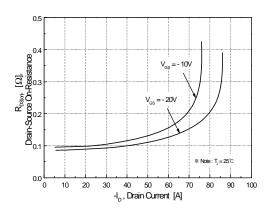


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

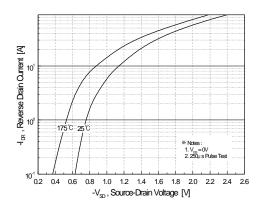


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

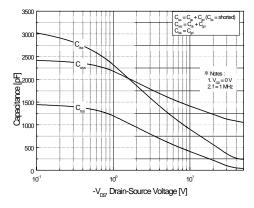


Figure 5. Capacitance Characteristics

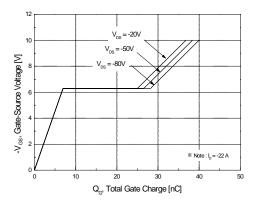
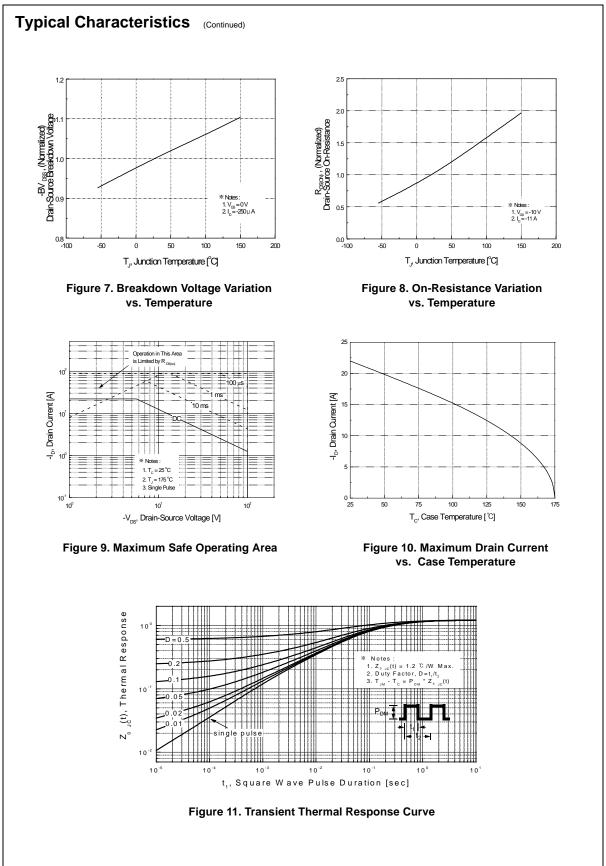


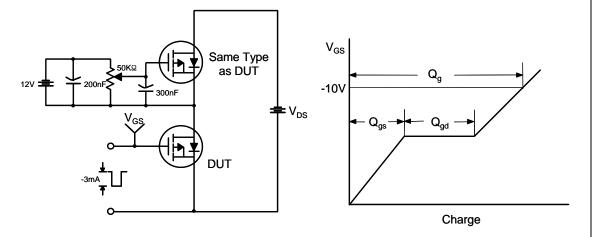
Figure 6. Gate Charge Characteristics

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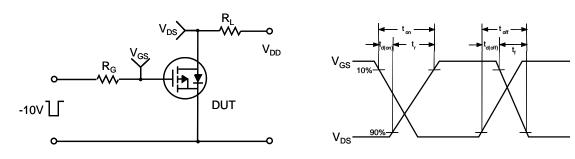


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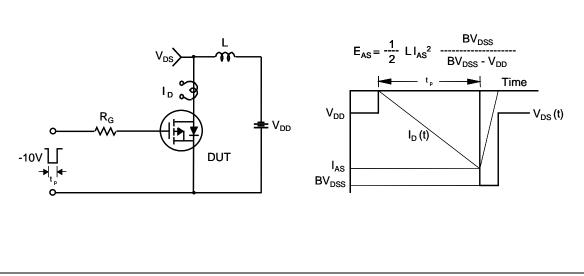
Gate Charge Test Circuit & Waveform



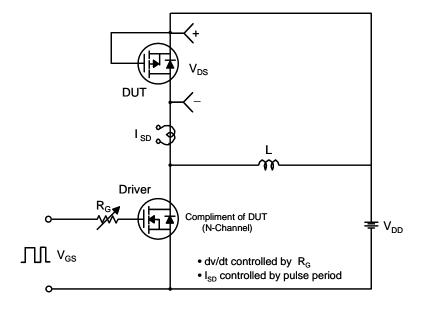
Resistive Switching Test Circuit & Waveforms

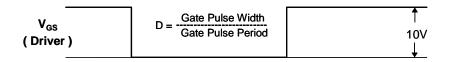


Unclamped Inductive Switching Test Circuit & Waveforms

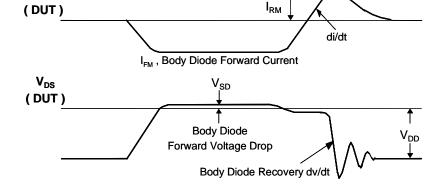


Peak Diode Recovery dv/dt Test Circuit & Waveforms



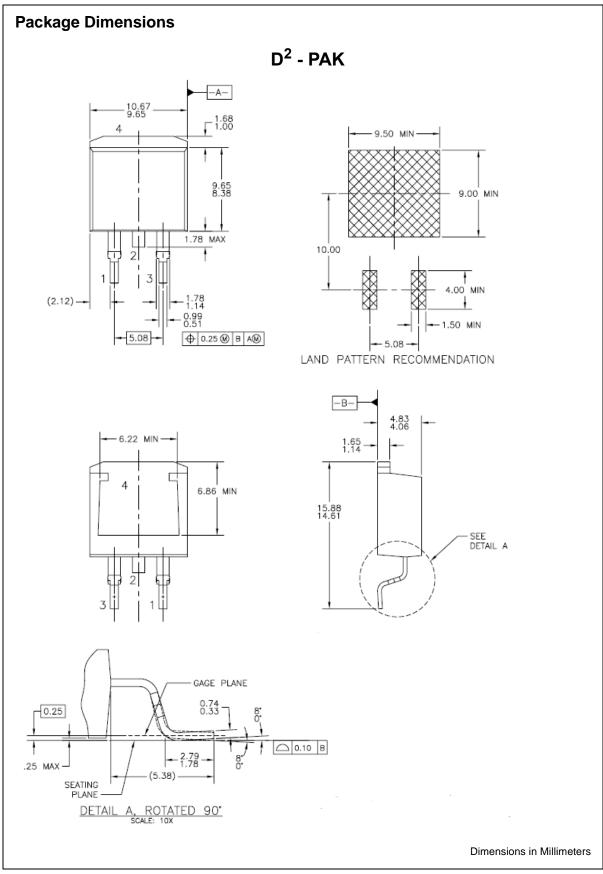


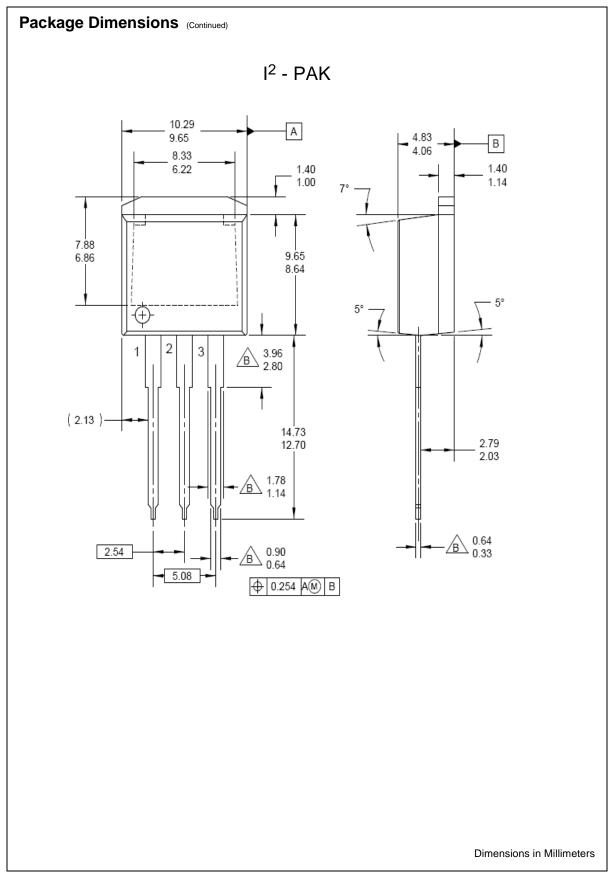
Body Diode Reverse Current



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